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Substitute for form 1449A/B/PTO			Complete if Known		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)			Application Number	10/574,186	
			Filing Date	March 30, 2006	
			First Named Inventor	Didier Pribat, et al.	
			Art Unit	To be assigned	
			Examiner Name	To be assigned	
Sheet	1	of	2	Attorney Docket Number	28944/50030

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		5,314,569	05-24-1994	Pribat et al.	
		6,346,189-B1	02-12-2002	Dai Hongjie et al.	
		2002/0136681-A1	09-26-2002	Thess Andreas et al.	

2002/0136681

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		FR 2 658 839-A1	09-13-1991	Thomson-CSF-FR.	
		WO 00/73204-A	12-07-2000	Dei Li Ming	
		EP 1 331 202-A	07-30-2003	Samsung Sdi Co Ltd	
		WO 03/060010-A	08-21-2003	Ajayan Pulickal M.	

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NON PATENT LITERATURE DOCUMENTS				
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.		
		Li J. et al., "Highly-Ordered Carbon nanotube Arrays for Electronics Applications," Applied Physics Letters, American Institute of Physics, Vol. 75, No. 3, pages 367-369, (July 19, 1999).		
		Wu et al., "Block-by-Block Growth of Single-Crystalline Si/SiGe Superlattice Nanowires," Nano Letters, Vol. 2, No. 2, pages 83-86, (2002).		
		Kornelius Nielsch et al., "Uniform Nickel Deposition into Ordered Alumina Pores by Pulsed Electrodeposition," Advanced Materials, Vol. 12, No. 8, pages 582-586, (2000).		
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		P. Evans, "Electrodeposition of Epitaxial Nickel Films on GaAs," Journal of Magnetism and Magnetic Materials, 260, pages 467-472, (2003).		
		X. Hoffer et al., "Spin-Dependent Magnetoresistance and Spin-Charge Separation in Multiwall Carbon Nanotubes," arXiv:cond-mat/0303314v2, 3 pages, (2003).		
		K. Lew et al., "Growth Characteristics of Silicon Nanowires Synthesized by Vapor-Liquid-Solid Growth in Nanoporous Alumina Templates," Journal of Crystal Growth, Vol. 254, No. 1-2, pages 14-16, (2003).		
		Sui et al., "Structure Thermal Stability, and Deformation of Multibranched Carbon Nanotubes Synthesized by CVD in the AAO Template," Journal of Physical Chemistry, Vol. 105, No. 8, pages 1523-1527, (2001).		
		Knutson et al., "Reactivity of Surfaces and Imaging with Functional NSOM," Electrochimica Acta, Vol. 48, No. 20-22, pages 3229-3237, (2003).		

Examiner Signature	/Daren Wolverton/	Date Considered	11/25/2008
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Sheet	2	of	2		

		Preliminary French Search Report FR 0311959; report dated July 30, 2004.	
		International Search Report PCT/FR2004/002584; report dated March 22, 2005.	

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